

MJ N-Channel and P-Channel Enhancement Mode Power MOSFET

Description

The MJ01NP03S uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge. This device is suitable for use in inverter and other applications.

General Features

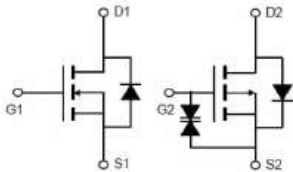
N-Channel

- ◆ $V_{DS}=100V, I_D=3A$
 $R_{DS(ON)}<130m\Omega$ @ $V_{GS}=10V$
 $R_{DS(ON)}<140m\Omega$ @ $V_{GS}=4.5V$

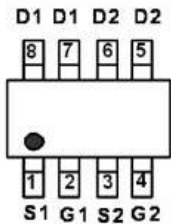
P-Channel

- ◆ $V_{DS}=-100V, I_D=-3A$
 $R_{DS(ON)}<200m\Omega$ @ $V_{GS}=-10V$
 $R_{DS(ON)}<230m\Omega$ @ $V_{GS}=-4.5V$

- ◆ High power and current handing capability
- ◆ Lead free product is acquired



Schematic diagram



Marking and pin assignment



SOP-8 top view

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MJ01NP03S	MJ01NP03S	SOP-8	Ø330mm	12mm	4000 units

Absolute Maximum Ratings ($T_c=25\text{ }^{\circ}\text{C}$ unless otherwise noted)

Parameter		Symbol	N-Channel	P-Channel	Unit
Drain-Source Voltage		V_{DS}	100	-100	V
Gate-Source Voltage		V_{GS}	±20	±20	V
Drain Current-Continuous ^(Note 2)	$T_A=25^{\circ}\text{C}$	I_D	3	-3	A
	$T_A=70^{\circ}\text{C}$	I_D	2.45	-2.45	A
Drain Current -Pulsed ^(Note 1)		I_{DM}	12	-12	A
Power Dissipation	$T_A=25^{\circ}\text{C}$	P_D	2	2	W
Operating Junction and Storage Temperature Range		T_J, T_{STG}	-55 To 150	-55 To 150	$^{\circ}\text{C}$

Thermal Characteristic

Parameter	Symbol	Typ	Max	Unit
Thermal Resistance, Junction-to-Ambient ^(Note 2) (N-channel)	$R_{\theta JA}$	-	62.5	$^{\circ}\text{C/W}$
Thermal Resistance, Junction-to-Ambient ^(Note 2) (P-channel)	$R_{\theta JA}$	-	62.5	$^{\circ}\text{C/W}$

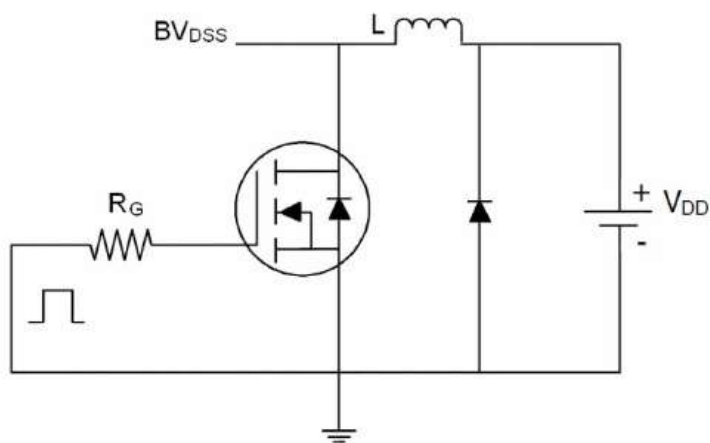
N-channel Electrical Characteristics (T_c=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	100	110	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =100V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{DS} =±20V,V _{GS} =0V	-	-	±100	nA
On Characteristics <small>(Note 3)</small>						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250μA	1.0	1.5	2.0	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =3A	-	95	130	mΩ
		V _{GS} =4.5V, I _D =3A	-	100	140	mΩ
Forward Transconductance	g _{FS}	V _{DS} =5V,I _D =3A	3.5	-	-	S
Dynamic Characteristics <small>(Note 4)</small>						
Input Capacitance	C _{iss}	V _{DS} =50V,V _{GS} =0V F=1.0MHz	-	730	-	PF
Output Capacitance	C _{oss}		-	37	-	PF
Reverse Transfer Capacitance	C _{rss}		-	27	-	PF
Switching Characteristics <small>(Note 4)</small>						
Turn-on Delay Time	t _{d(on)}	V _{DD} =50V, R _L =15Ω V _{GS} =10V,R _G =2.5Ω	-	11	-	nS
Turn-on Rise Time	t _r		-	7.4	-	nS
Turn-Off Delay Time	t _{d(off)}		-	35	-	nS
Turn-Off Fall Time	t _f		-	9.1	-	nS
Total Gate Charge	Q _g	V _{DS} =50V,I _D =3A V _{GS} =10V	-	21.5	-	nC
Gate-Source Charge	Q _{gs}		-	3.2	-	nC
Gate-Drain Charge	Q _{gd}		-	6	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage <small>(Note 3)</small>	V _{SD}	V _{GS} =0V,I _S =3A	-	-	1.2	V
Diode Forward Current <small>(Note 2)</small>	I _S		-	-	3	A
Reverse Recovery Time	t _{rr}	T _J =25°C, I _F =3A di/dt=100A/μs <small>(Notes)</small>	-	26	-	nS
Reverse Recovery Charge	Q _{rr}		-	27	-	nC
Forward Turn-On Time	ton	Intrinsic turn-on time is negligible(turn-on is dominated by LS+LD)				

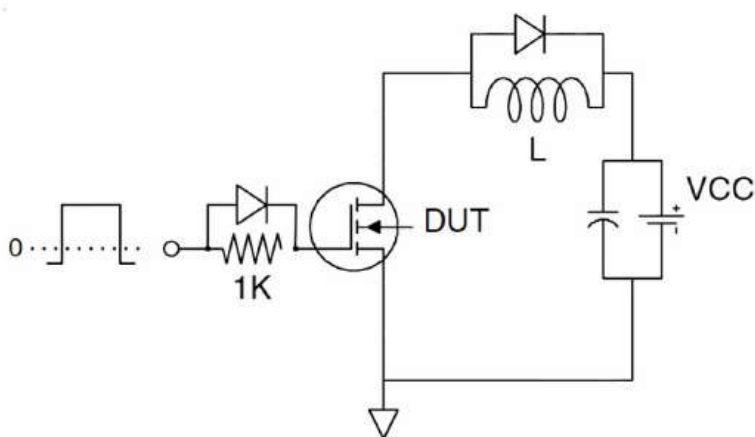
Notes:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② The value of R_{θJA} is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The value in any given application depends on the user's specific board design.Surface Mounted on FR4 Board, t ≤ 10 sec. The current rating is based on the t ≤10s thermal resistance rating.
- ③ Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
- ④ Guaranteed by design, not subject to production

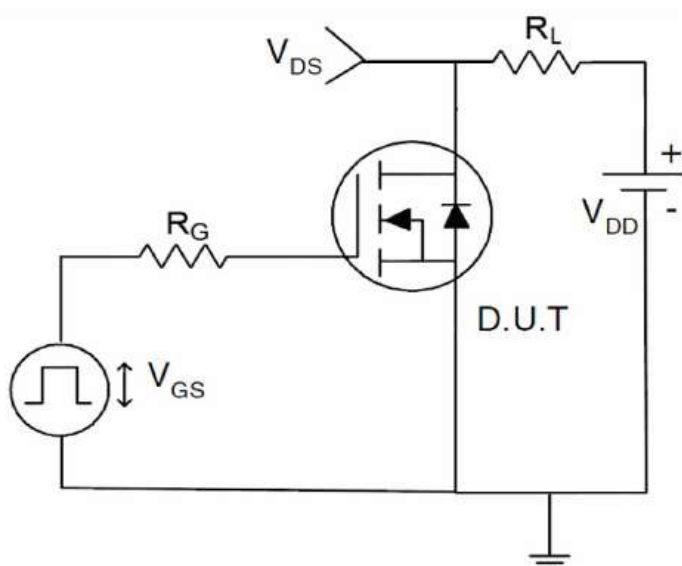
Test circuit



EAS test Circuit

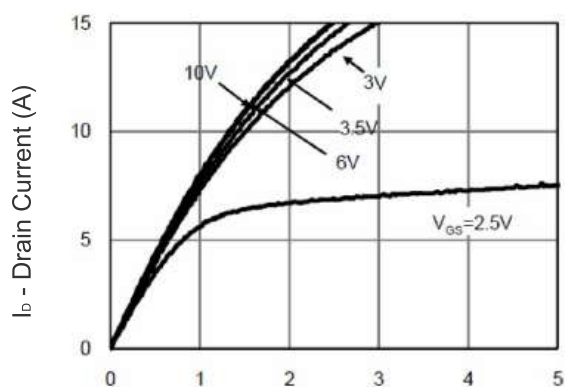


Gate charge test Circuit

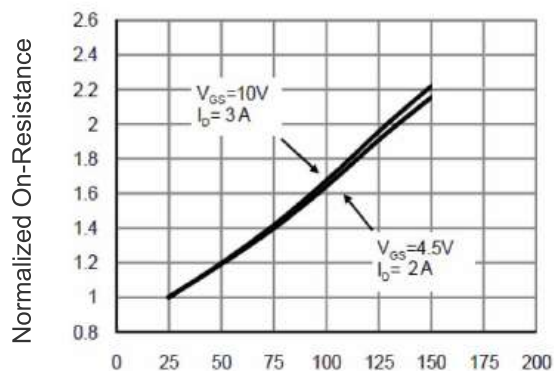


Switch Time Test Circuit

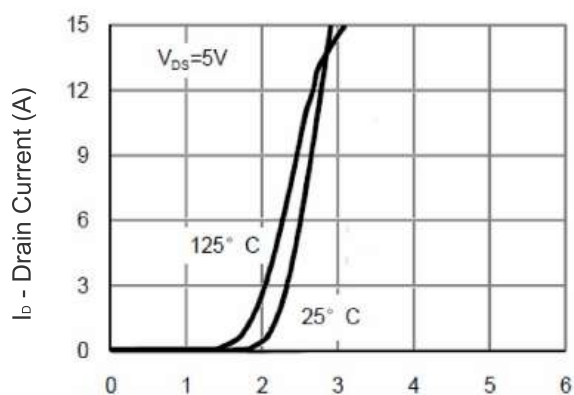
N-channel Typical Electrical and Thermal Characteristics (Curves)



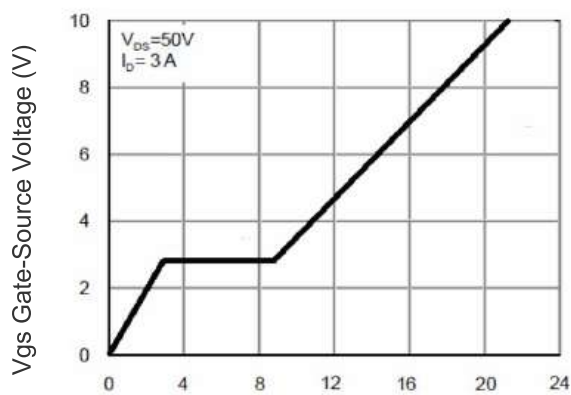
V_{ds} Drain-Source Voltage (V)
Figure 1 Output Characteristics



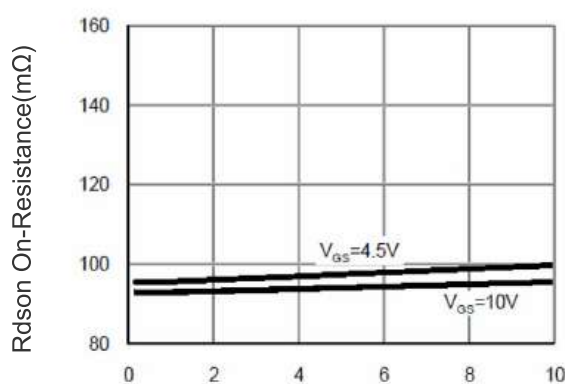
T_J Junction Temperature(°C)
Figure 4 Rdson-Junction Temperature



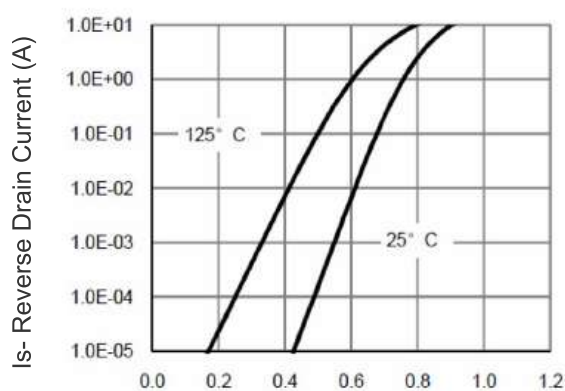
V_{gs} Gate-Source Voltage (V)
Figure 2 Transfer Characteristics



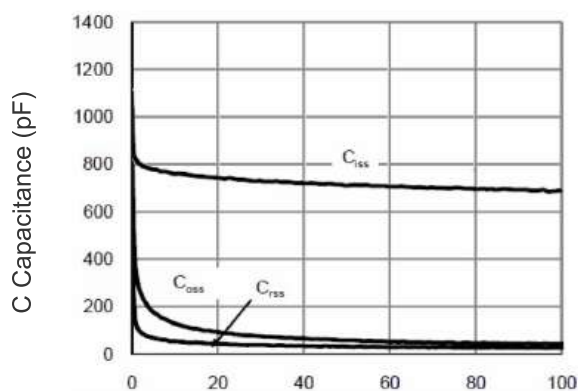
Q_g Gate Charge (nC)
Figure 5 Gate Charge



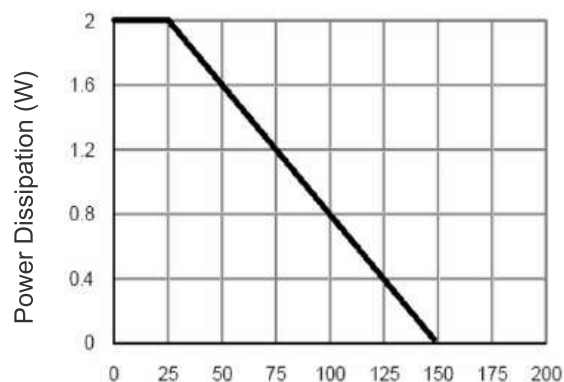
I_D- Drain Current (A)
Figure 3 Rdson- Drain Current



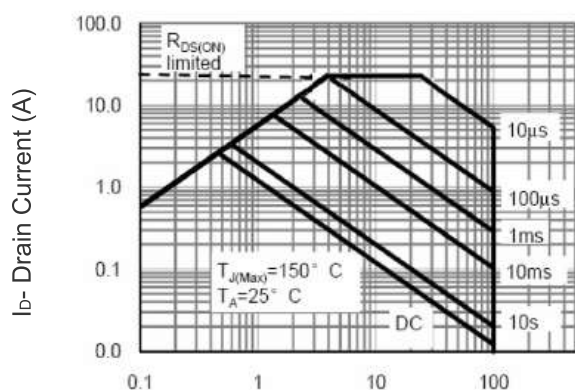
V_{sd} Source-Drain Voltage (V)
Figure 6 Source- Drain Diode Forward



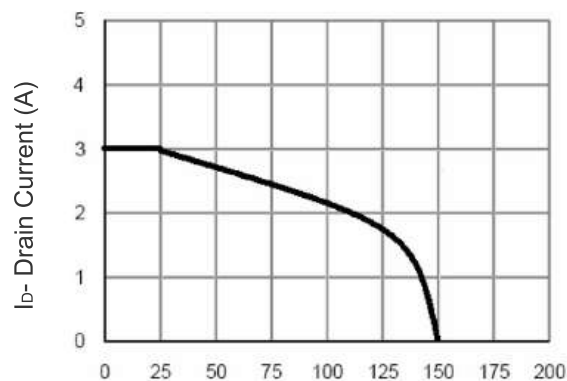
Vds Drain-Source Voltage (V)
Figure 7 Capacitance vs Vds



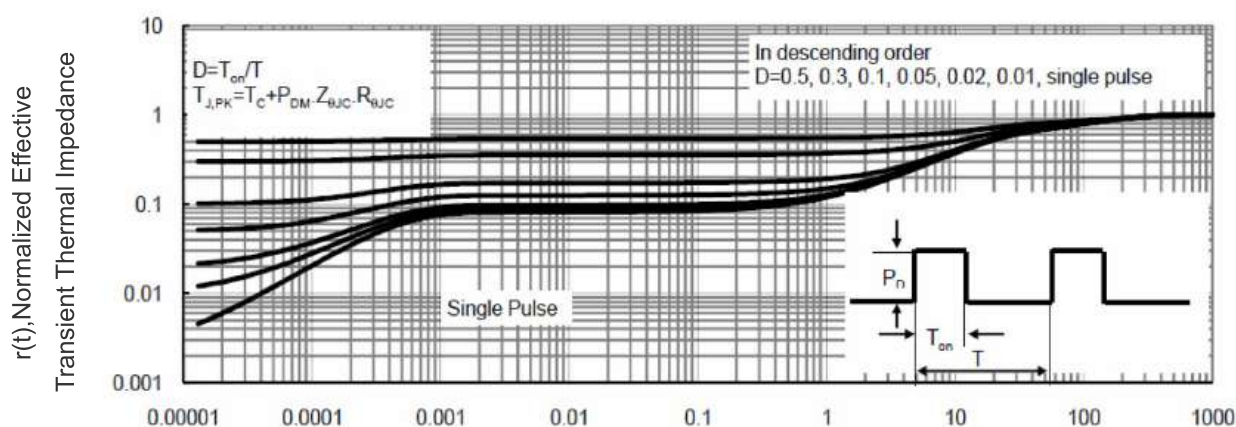
TJ -Junction Temperature(°C)
Figure 9 Power De-rating



Vds Drain-Source Voltage (V)
Figure 8 Safe Operation Area



TJ -Junction Temperature(°C)
Figure 10 Current De-rating



Square Wave Pluse Duration(sec)
Figure 11 Normalized Maximum Transient Thermal Impedance

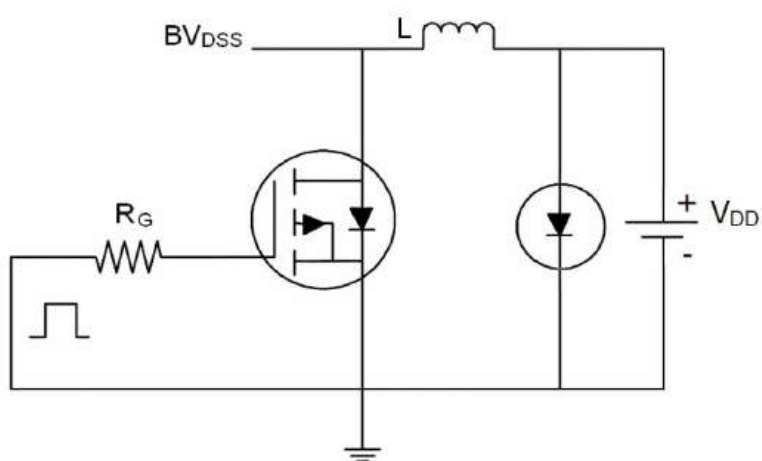
P-channel Electrical Characteristics (T_A=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =-250μA	-100	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-100V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{DS} =±20V,V _{GS} =0V	-	-	±10	μA
On Characteristics <small>(Note 3)</small>						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =-250μA	-1	-1.9	-3	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =-10V, I _D =-3A	-	170	200	mΩ
		V _{GS} =-4.5V, I _D =-2A	-	200	230	mΩ
Forward Transconductance	g _{FS}	V _{DS} =-5V,I _D =-3A	2	-	-	S
Dynamic Characteristics <small>(Note 4)</small>						
Input Capacitance	C _{iss}	V _{DS} =-25V,V _{GS} =0V, F=1.0MHz	-	760	-	PF
Output Capacitance	C _{oss}		-	260	-	PF
Reverse Transfer Capacitance	C _{rss}		-	170	-	PF
Switching Characteristics <small>(Note 4)</small>						
Turn-on Delay Time	t _{d(on)}	V _{DD} =-50V,I _D =-3A V _{GS} =-10V,R _{GEN} =9Ω	-	14	-	nS
Turn-on Rise Time	t _r		-	18	-	nS
Turn-Off Delay Time	t _{d(off)}		-	50	-	nS
Turn-Off Fall Time	t _f		-	18	-	nS
Total Gate Charge	Q _g	V _{DS} =-50V,I _D =-3A V _{GS} =-10V	-	25	-	nC
Gate-Source Charge	Q _{gs}		-	5	-	nC
Gate-Drain Charge	Q _{gd}		-	7	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage <small>(Note 3)</small>	V _{SD}	V _{GS} =0V,I _S =-3A	-	-	-1.2	V
Diode Forward Current <small>(Note 2)</small>	I _S		-	-	-3	A
Reverse Recovery Time	t _{rr}	T _J =25°C, I _F =-3A di/dt=100A/μs <small>(Note 3)</small>	-	35	-	nS
Reverse Recovery Charge	Q _{rr}		-	46	-	nC
Forward Turn-On Time	ton	Intrinsic turn-on time is negligible(turn-on is dominated by LS+LD)				

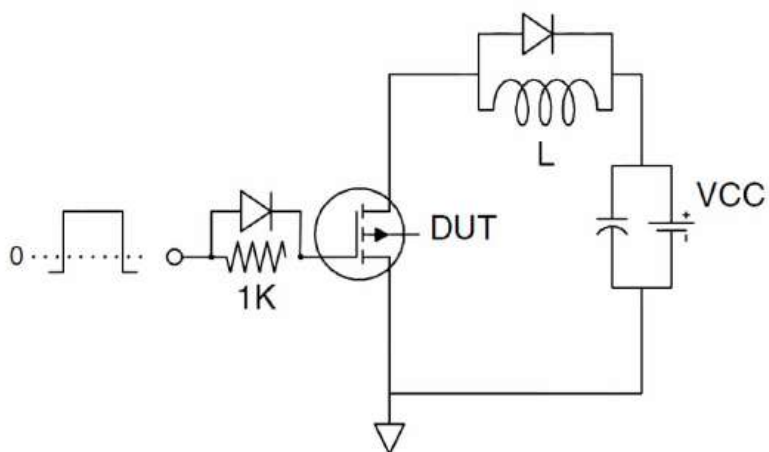
Notes:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board, t ≤ 10 sec.
- ③ Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
- ④ Guaranteed by design, not subject to production
- ⑤ EAS condition: T_J=25°C,V_{DD}=-50V,V_G=-10V,L=0.5mH,R_g=25Ω.

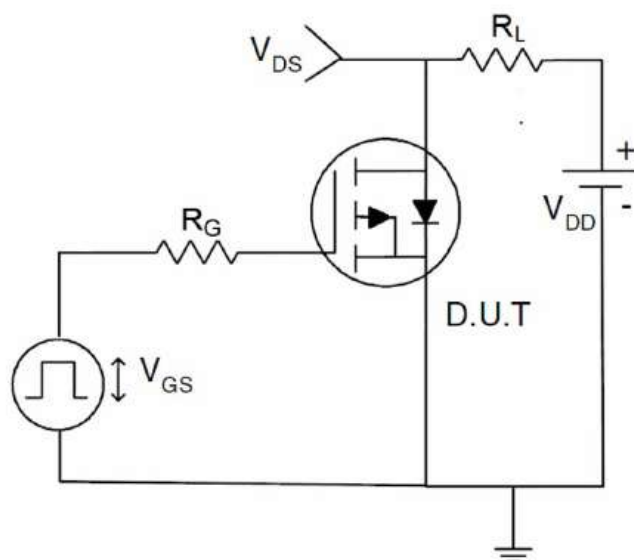
Test circuit



EAS test Circuit



Gate charge test Circuit



Switch Time Test Circuit

Typical Electrical and Thermal Characteristics (Curves)

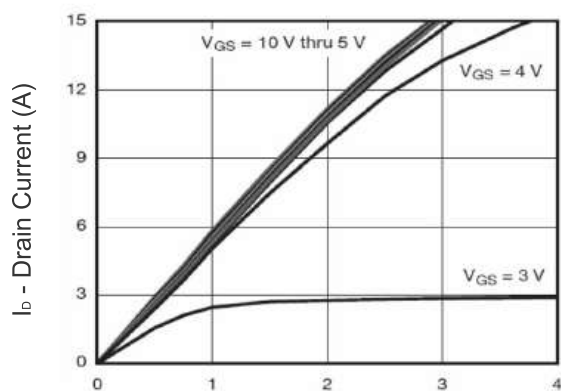


Figure 1 Output Characteristics

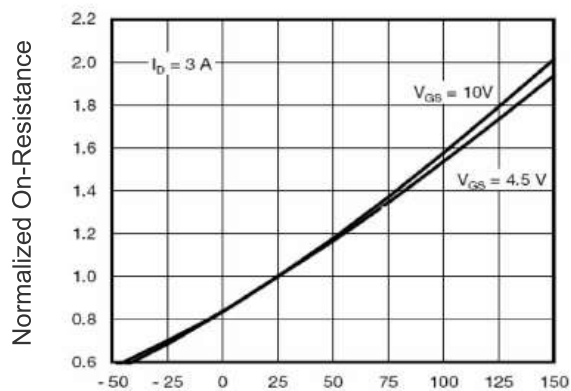


Figure 4 $R_{DS(on)}$ -Junction Temperature

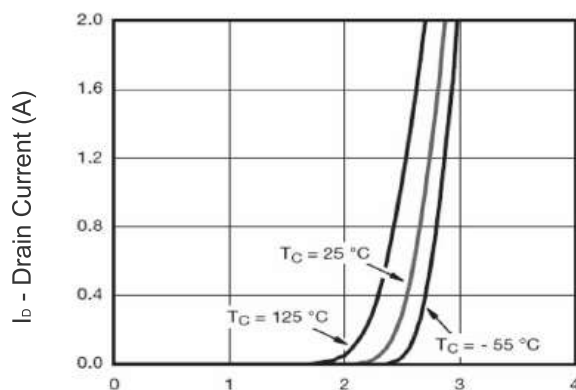


Figure 2 Transfer Characteristics

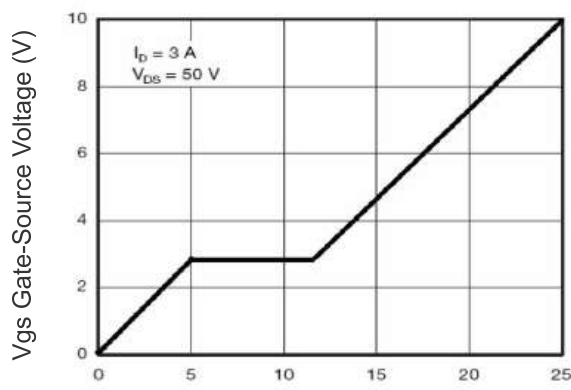


Figure 5 Gate Charge

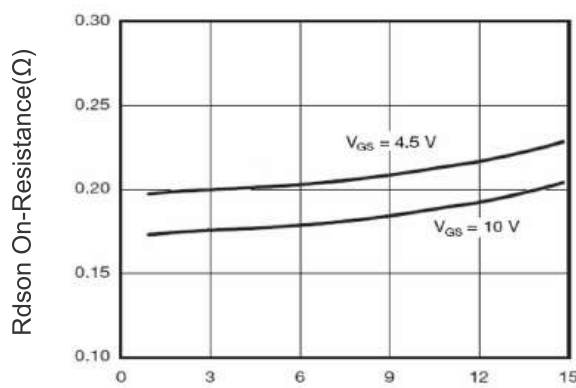


Figure 3 $R_{DS(on)}$ - Drain Current

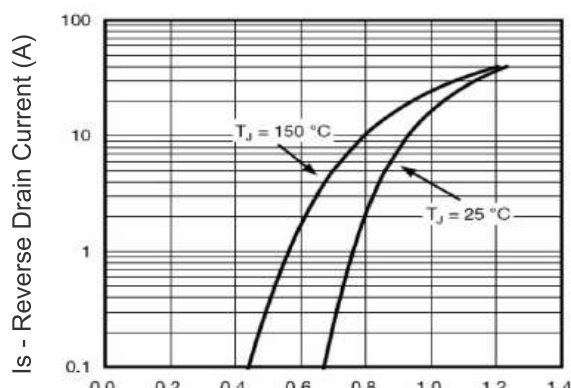
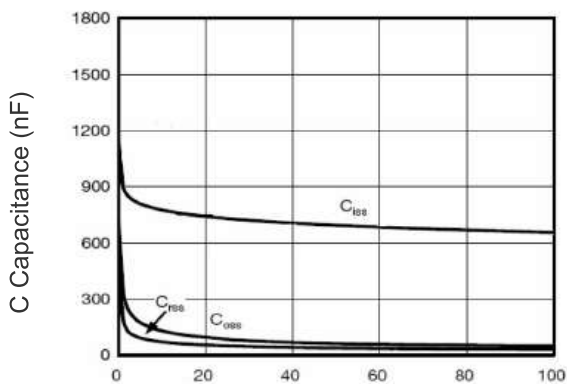
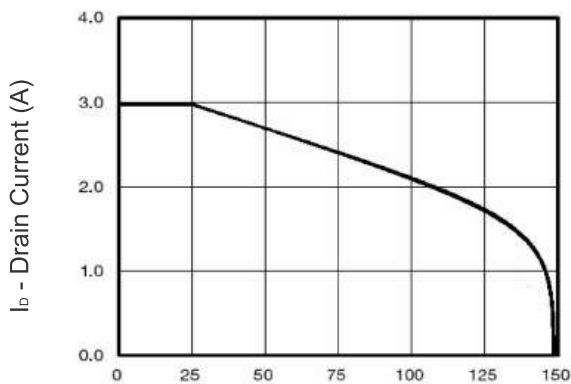


Figure 6 Source- Drain Diode Forward



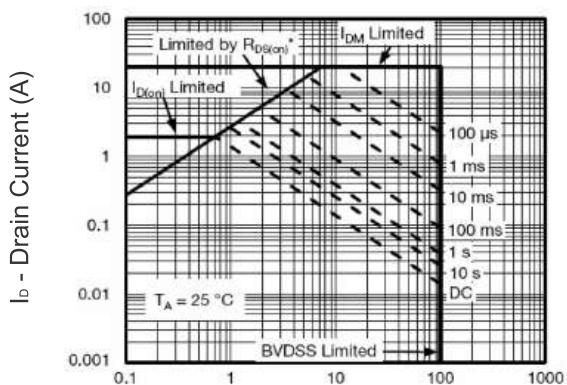
Vds Drain-Source Voltage (V)

Figure 7 Capacitance vs Vds



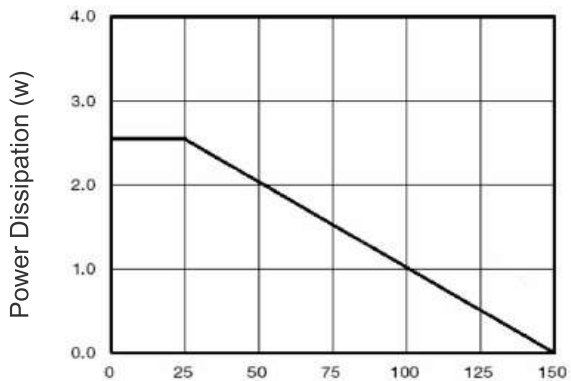
Tc Case Temperature(°C)

Figure 9 Drain Current vs Case Temperature



Vds Drain-Source Voltage (V)

Figure 8 Safe Operation Area



TJ -Junction Temperature(°C)

Figure 10 Power De-rating

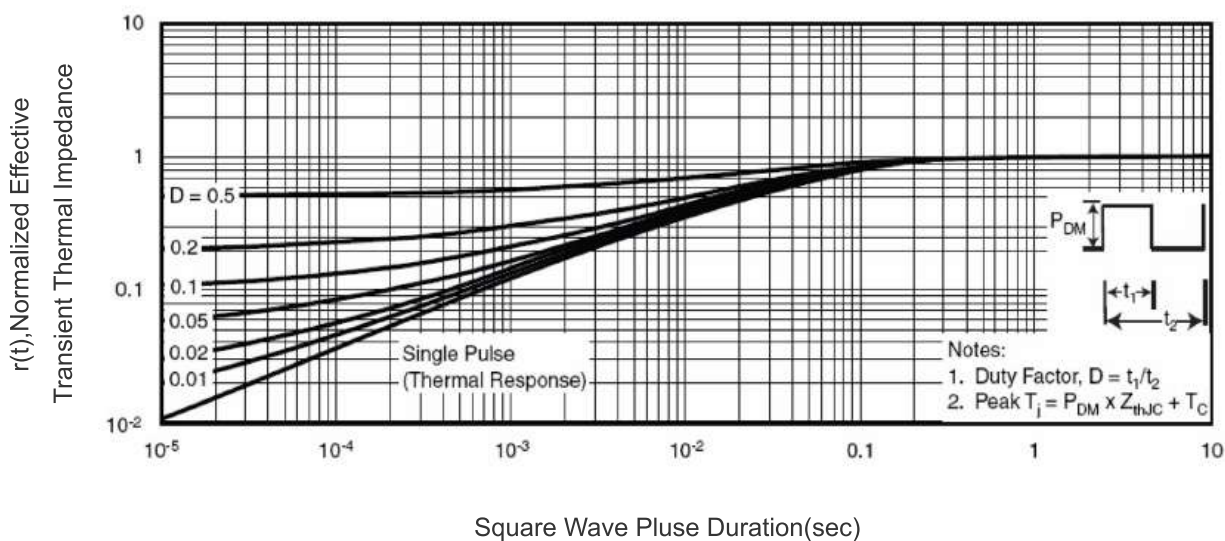
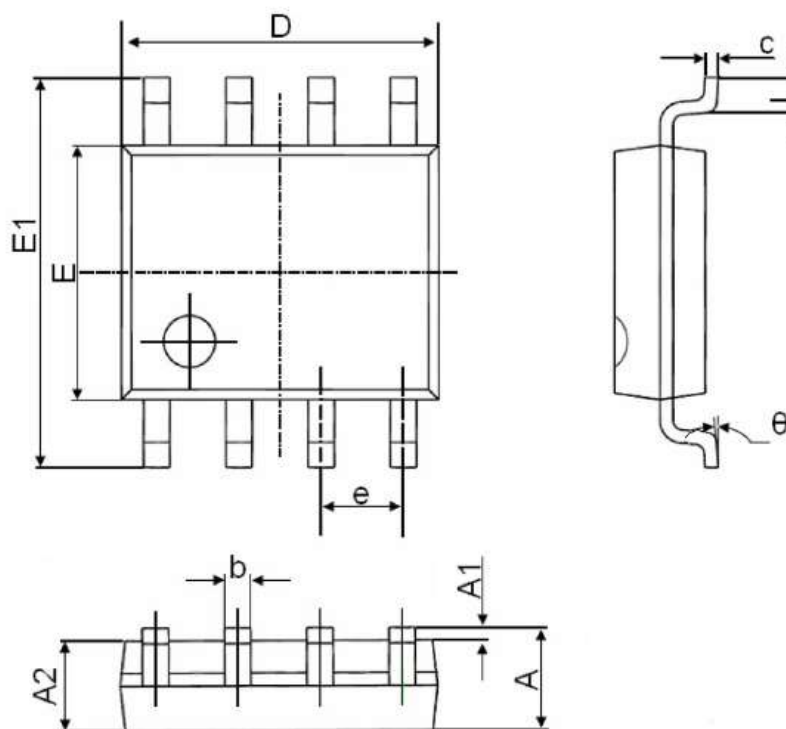


Figure 11 Normalized Maximum Transient Thermal Impedance

SOP-8 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°

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